

Notice of References Cited	Application/Control No. 10/605,097	Applicant(s)/Patent Under Reexamination WENG, YIH-SHIN	
	Examiner Parul Gupta	Art Unit 2627	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0181356	12-2002	Watanabe et al.	369/47.16
*	B	US-6,115,343	09-2000	Narumi et al.	369/59.2
*	C	US-6,185,640	02-2001	Ross, Kevin	710/53
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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